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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		196880US2 SRD	SERIAL NO. 09/652,010					
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Katsuyuki NAITO et al.						
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE			
Ð√	AA	6,197,399	03/06/01	NAITO et al.	_					
PV	AB	6,125,095	09/26/00	GEMMA et al.						
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BV	AA	5.027,216	06/25/91	I. TAKANASHI, et al.		_					
RV	AB	3,801,966	04/02/74	M. TERAO	1						
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RV	AO	57-123541	08/02/82	JAPAN (with English Abstract)			Х				
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BV	AW	Patent Abstracts of Ja	pan, JP 60-212	2843, October 25, 1985							
13√	AX	Patent Abstracts of Ja	pan, JP 57-135	5445, August 21, 1982							
13V	AY	Patent Abstracts of Japan, JP 10-289496, October 27, 1998									
	AZ		Additional References sheet(s) attached								
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